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2	IS&R	L2	173	(348/92).CCLS.	US- PGPUB; USPAT	2007/02/08 10:44	
3	BRS	L3	33	(3-d or 3d or (three near1 dimension\$3)) same imag\$3 same (part\$1 or manufactured) same (flaw\$1 or defect\$4 or crack\$1 or void\$1) same (identif\$6 or match\$4 or compar\$6 or collat\$4 or correlat\$4) same (locat\$4 or position\$3 or spatial or co-ordinate\$1 or coordinate\$1)	US- PGPUB; USPAT	2007/02/08 11:00	
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7	BRS	L7	4281	display\$3 with (part\$1 or image\$1) with (flaw\$1 or void\$1 or defect\$4)	US- PGPUB; USPAT	2007/02/08 10:59	

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11	BRS	L11	5	(identif\$6 near3 (flaw\$1 or defect\$4 or void\$1 or crack\$1)) same (align\$5 or documented or documenting or correct\$3) same (inspect\$4 or test\$3) same imag\$3 same ((three near1 dimension\$3) or 3d or 3-d)	US- PGPUB; USPAT	2007/02/08 11:14	
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14	BRS	L14	18	13 same cad	US- PGPUB; USPAT	2007/02/08 11:15	
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22	BRS	L22	14	mariam and (part\$1 near9 inspect\$5)	US- PGPUB; USPAT	2007/02/08 11:57	
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<p><u>L6</u> 6173066.pn.</p>	<p>1</p>	<p><u>L6</u></p>
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<u>L9</u>	L8 same (inspect\$4 or test\$3)	17	<u>L9</u>
<u>L10</u>	l1 same manufactur\$3	262	<u>L10</u>
<u>L11</u>	l10 same ((locat\$4 or identif\$4 or detect\$4 or judg\$5) near4 (flaw\$1 or defect\$4 or crack\$1 or void\$1 or (lack near1 fusion near1 weld) or (incomplete\$1 near1 weld) or rivet))	122	<u>L11</u>
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<u>L14</u>	L12 same ((test\$3 or inspect\$4) near7 part\$1)3	0	<u>L14</u>
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Nondestructive testing of specularly reflective objects using ...

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Alongside **non-destructive** material testing, tasks involving measurement and ... Those **images** are subsequently computed to create a **three-dimensional image**. ...
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
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On-Line Testing Symposium, 2006. IOLTS 2006. 12th IEEE International
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